

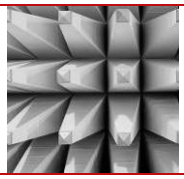

CETECOM™
CETECOM ICT Services
consulting - testing - certification

TEST REPORT

Test report no.: 1-5412/12-01-11-B

ilac-MRA DAkkS Deutsche Akkreditierungsstelle D-PL-12076-01-01

Testing laboratory

CETECOM ICT Services GmbH
Untertuerkheimer Strasse 6 – 10
66117 Saarbruecken / Germany
Phone: + 49 681 5 98 - 0
Fax: + 49 681 5 98 - 9075
Internet: http://www.cetecom.com
e-mail: ict@cetecom.com

Accredited Testing Laboratory:
The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)
The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-01
Area of Testing: Radio/Satellite Communications

Applicant

Mobotix AG
Kaiserstr.
67722 Winnweiler / GERMANY
Phone: +49 6302 9816-0
Contact: Thomas Kern
e-mail: thomas.kern@mobotix.com
Phone: +49 6302-9816-0

Manufacturer

Mobotix AG
Kaiserstr.
67722 Winnweiler / GERMANY

Test standard/s

47 CFR Part 15	Title 47 of the Code of Federal Regulations; Chapter I Part 15 - Radio frequency devices
RSS - 210 Issue 8	Spectrum Management and Telecommunications - Radio Standards Specification Low-power Licence-exempt Radiocommunication Devices (All Frequency Bands): Category I Equipment

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item:	**RFID Reader**
Model name:	**Keypad-B**
FCC ID:	**YYRKPADB**
IC:	**9357A-KPADB**
Frequency:	13.56 MHz
Technology tested:	RFID
Antenna:	Integrated loop antenna
Power Supply:	48V DC by external power supply
Temperature Range:	-20°C to +55°C

This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorised:

cn=Christoph Schneider, o=CETECOM ICT Services GmbH, ou=SND-120402, email=christoph.schneider@cetecom.com, c=DE
2013.07.12 11:04:48 +02'00'

Christoph Schneider
Expert

Test performed:

p.o.
cn=Stefan Boes, o=CETECOM ICT Services GmbH, ou=BOE-111011, email=Stefan.Boes@cetecom.com, c=DE
2013.07.12 10:17:21 +02'00'

Tobias Wittenmeier
Expert

1 Table of contents

2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.
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This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

2.2 Application details

Date of receipt of order:	2012-11-28
Date of receipt of test item:	2013-02-25
Start of test:	2013-02-25
End of test:	2013-03-01
Person(s) present during the test:	-/-

3 Test standard/s

Test standard	Date	Test standard description
47 CFR Part 15	2010-10	Title 47 of the Code of Federal Regulations; Chapter I Part 15 - Radio frequency devices
RSS - 210 Issue 8	2010-12	Spectrum Management and Telecommunications - Radio Standards Specification Low-power Licence-exempt Radiocommunication Devices (All Frequency Bands): Category I Equipment

4 Test environment

Temperature:	T_{nom}	+22 °C	during room temperature tests
	T_{max}	+55 °C	during high temperature tests
	T_{min}	-20 °C	during low temperature tests
Relative humidity content:		55 %	
Barometric pressure:		not relevant for this kind of testing	
Power supply:	V_{nom}	48 V	DC by external power supply
	V_{max}	54 V	
	V_{min}	20 V	

5 Test item

Kind of test item	**:**	**RFID Reader**
Type identification	**:**	**Keypad-B**
S/N serial number	**:**	**Unknown**
HW hardware status	**:**	**Unknown**
SW software status	**:**	**Unknown**
Frequency band [MHz]	**:**	**13.56 MHz**
Type of radio transmission **Use of frequency spectrum**	**:** **:**	**single carrier**
Type of modulation	**:**	**ASK**
Number of channels	**:**	**1**
Antenna	**:**	**Integrated loop antenna**
Power supply	**:**	**48 V DC by external power supply**
Temperature range	**:**	**-20°C to +55 °C**

6 Test laboratories sub-contracted

None

7 Additional information

Test setup - and EUT - photos are included in the following test reports:

External EUT photos: 1-5412/12-01-11-B_AnnexA
Internal EUT photos: 1-5412/12-01-11-B_AnnexB
Test setup: 1-5412/12-01-11-B_AnnexC

8 Summary of measurement results

☒ **No deviations from the technical specifications were ascertained**

☐ There were deviations from the technical specifications ascertained

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS 210, Issue 8, Annex 2.6	Passed	2013-07-12	-/-

Test Specification Clause	Test Case	Temperature Conditions	Power Source Voltages	Pass	Fail	NA	NP	Remark
§ 15.35 (c)/ RSS-GEN Issue 3	Timing of the transmitter (Duty cycle correction factor)	Nominal	Nominal	☒	☐	☐	☐	complies
RSS-GEN Issue 3	99 % emission bandwidth	Nominal	Nominal	☒	☐	☐	☐	complies
§ 15.225 (a)/ RSS-210 Issue 8 Annex 2.6	Fieldstrength of Fundamental	Nominal	Nominal	☒	☐	☐	☐	complies
§ 15.209/ RSS-210 Issue 8 Annex 2.6	Fieldstrength of harmonics and spurious	Nominal	Nominal	☒	☐	☐	☐	complies
§ 15.225 (e)/ RSS-210 Issue 8 Annex 2.6	Frequency tolerance	Nominal	Extreme	☒	☐	☐	☐	complies
		Extreme	Nominal	☒	☐	☐	☐	
§15.107	Conducted emissions < 30 MHz (AC-line conducted)	Nominal	Nominal	☒	☐	☐	☐	complies

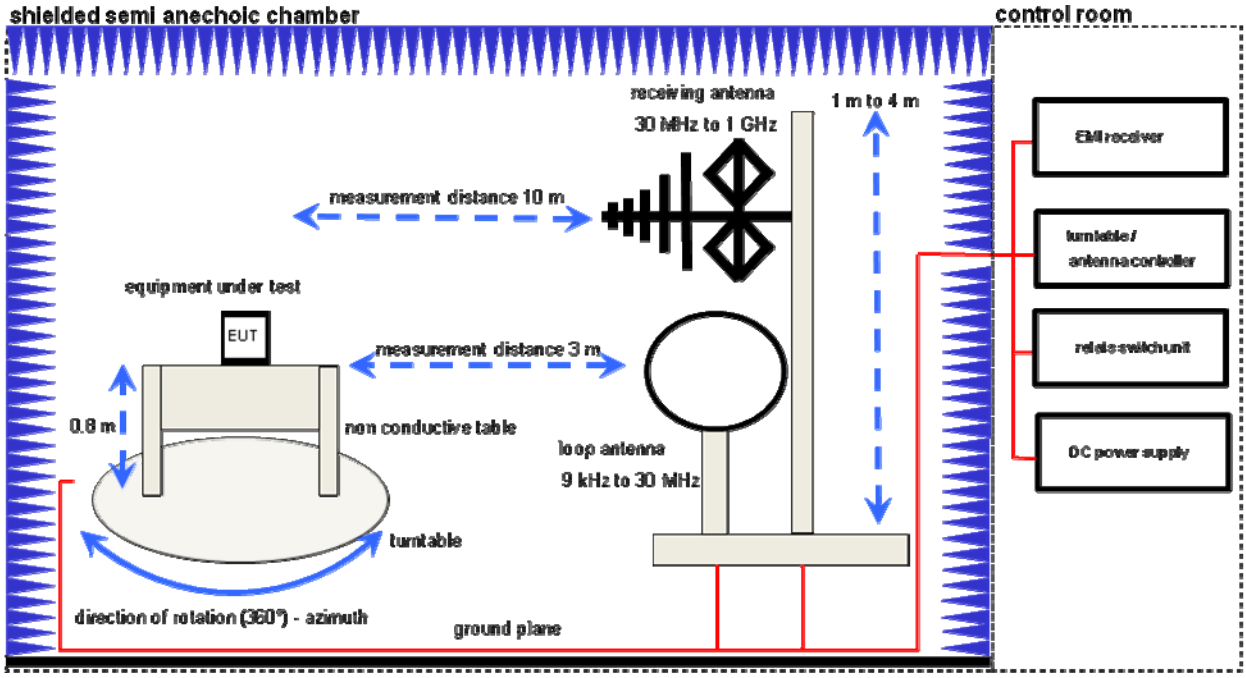
Note: NA = Not Applicable; NP = Not Performed

9 RF measurements

9.1 Description of test setup

9.1.1 Radiated measurements

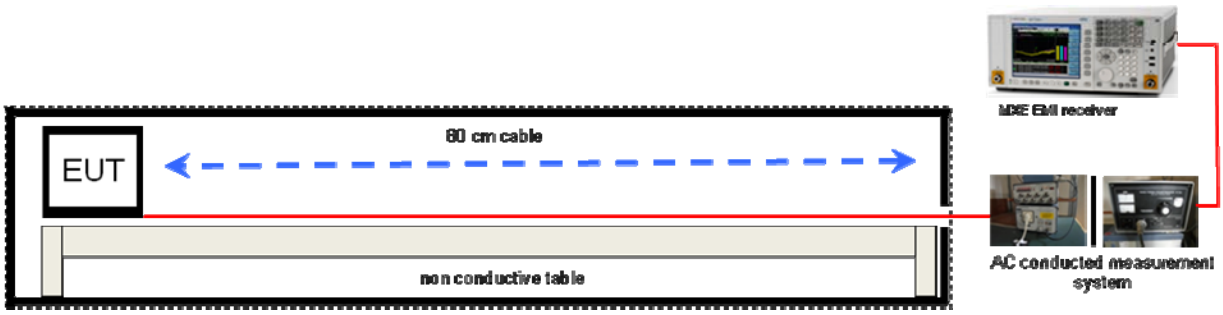
The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analysers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Equipment table:

Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom
Switch-Unit	3488A	HP Meßtechnik	2719A14505	300000368
DC power supply, 60Vdc, 50A, 1200 W	6032A	HP Meßtechnik	2920A04466	300000580
EMI Test Receiver	ESCI 3	R&S	100083	300003312
Amplifier	JS42-00502650-28-5A	MITEQ	1084532	300003379
Antenna Tower	Model 2175	ETS-LINDGREN	64762	300003745
Positioning Controller	Model 2090	ETS-LINDGREN	64672	300003746
Turntable Interface-Box	Model 105637	ETS-LINDGREN	44583	300003747
TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787
Test Receiver	ESH2	R&S	871921/095	300002505
Loop Antenna 9 KHz - 30 MHz	HFH2-Z2	R&S	872096/61	300001824
EMI Test Receiver 9 kHz - 3 GHz incl. Preselector	ESPI3	R&S	101713	300004059

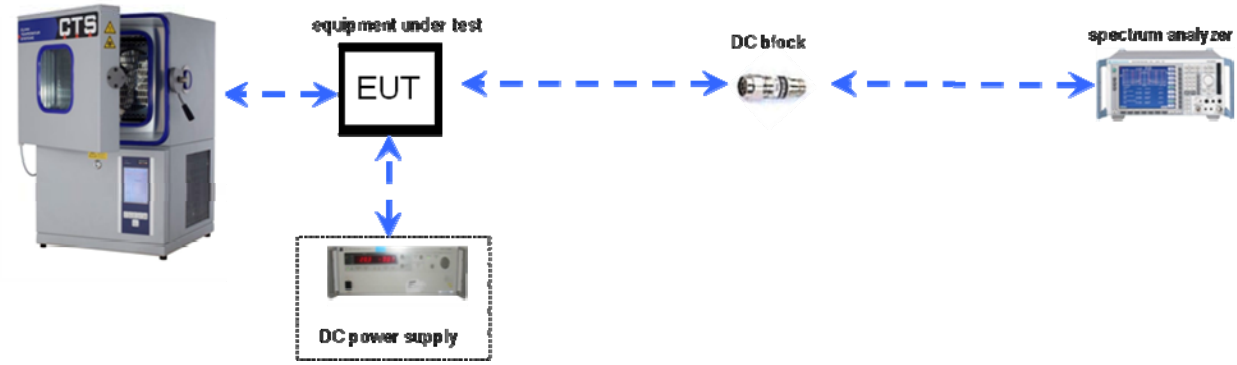
9.2 AC conducted



Equipment table:

Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom
MXE EMI Receiver 20 Hz bis 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405
Isolating Transformer	MPL IEC625 Bus Regeltrenntravo	Erfi	91350	300001155
Switch / Control Unit	3488A	HP Meßtechnik	*	300000199
Switch / Control Unit	3488A	HP Meßtechnik	2719A15013	300001168
Artificial Mains 9 kHz to 30 MHz	ESH3-Z5	R&S	828576/020	300001210

9.3 Conducted measurements



Equipment table:

Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom
DC Power Supply 0 – 32V	1108-32	Heiden	001802	300001383
Temperature Test Chamber	T-40/50	CTS GmbH	064023	300003540
Spectrum Analyzer 20 Hz - 50 GHz	FSU50	R&S	200012	300003443

9.4 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: None

9.5 RSP100 test report cover sheet / performance test data

Test Report Number	:	**1-5412/12-01-11-B**
Equipment Model Number	:	**Keypad-B**
Certification Number	:	**9357A-KPADB**
Manufacturer (complete Address)	:	**Mobotix AG Kaiserstr. 67722 Winnweiler / GERMANY**
Tested to radio standards specification no.	:	**RSS 210, Issue 8, A2.6**
Open Area Test Site IC No.	:	**IC 3462C-1**
Frequency Range or fixed frequency	:	**13.56 MHz**
Field Strength [dBµV/m] (at which distance)	:	**57.0 @ 10m**
Occupied bandwidth (99%-BW) [MHz]	:	**436 kHz**
Type of modulation	:	**ASK**
Emission Designator (TRC-43)	:	**436KA1D**
Antenna Information	:	**Integrated loop antenna**
Transmitter Spurious (worst case) [dBµV/m @ 10m]	:	**19.1 dBµV/m @ 40.63 MHz Quasi-Peak**

ATTESTATION:
DECLARATION OF COMPLIANCE:

I attest that the testing was performed or supervised by me; that the test measurements were made in accordance with the above-mentioned Industry Canada standard(s); and that the equipment identified in this application has been subjected to all the applicable test conditions specified in the Industry Canada standards and all of the requirements of the standard have been met.

Laboratory Manager:

2013-07-12	Tobias Wittenmeier	p.o. Stefan Boes	cn=Stefan Boes, o=CETECOM ICT Services GmbH, ou=BOE-111011, email=Stefan.Boes@cetecom.com, c=DE 2013.07.12 10:17:47 +02'00'
Date	Name	Signature	

10 Measurement results

10.1 Timing of the transmitter

Measurement:

Measurement parameter	
Detector:	Positive peak
Sweep time:	100 ms
Resolution bandwidth:	100 kHz
Video bandwidth:	300 kHz
Span:	Zero span
Trace-Mode:	Single sweep

Limits:

FCC	IC
Timing of the transmitter	
(c) Unless otherwise specified, e.g. Section 15.255(b), when the radiated emission limits are expressed in terms of the average value of the emission, and pulsed operation is employed, the measurement field strength shall be determined by averaging over one complete pulse train, including blanking intervals, as long as the pulse train does not exceed 0.1 seconds. As an alternative (provided the transmitter operates for longer than 0.1 seconds) or in cases where the pulse train exceeds 0.1 seconds, the measured field strength shall be determined from the average absolute voltage during a 0.1 second interval during which the field strength is at its maximum value. The exact method of calculating the average field strength shall be submitted with any application for certification or shall be retained in the measurement data file for equipment subject to notification or verification.	

EUT is transmitting continuously (100% duty cycle).

Result: **Passed**

10.2 Field strength of the fundamental

Measurement:

Measurement parameter	
Detector:	Quasi Peak
Resolution bandwidth:	200 Hz up to 150 kHz, 9 kHz up to 30 MHz, 120 kHz up to 1 GHz
Video bandwidth:	≥ RBW
Trace-Mode:	Max Hold

Limits:

FCC		IC
Fundamental Frequency (MHz)	**Field strength of Fundamental (µV/m / dBµV/m)**	**Measurement distance (m)**
13.553 to 13.567	15848 µV/m (84 dBµV/m)	30
	158489 µV/m (104 dBµV/m)	10 (Recalculated acc. to FCC part15.31 (f2)

Result:

TEST CONDITIONS		MAXIMUM POWER (dBµV/m)	
Frequency		13.56 MHz	13.56 MHz
Mode		at 10 m distance	at 30 m distance
T_{nom}	V_{nom}	57.0	37.0*
Measurement uncertainty		±3dB	

* Limits recalculated from 10m to 30m with 40 dB/decade according to FCC 15.31 (f2).

Result: **passed**

10.3 99 % emission bandwidth

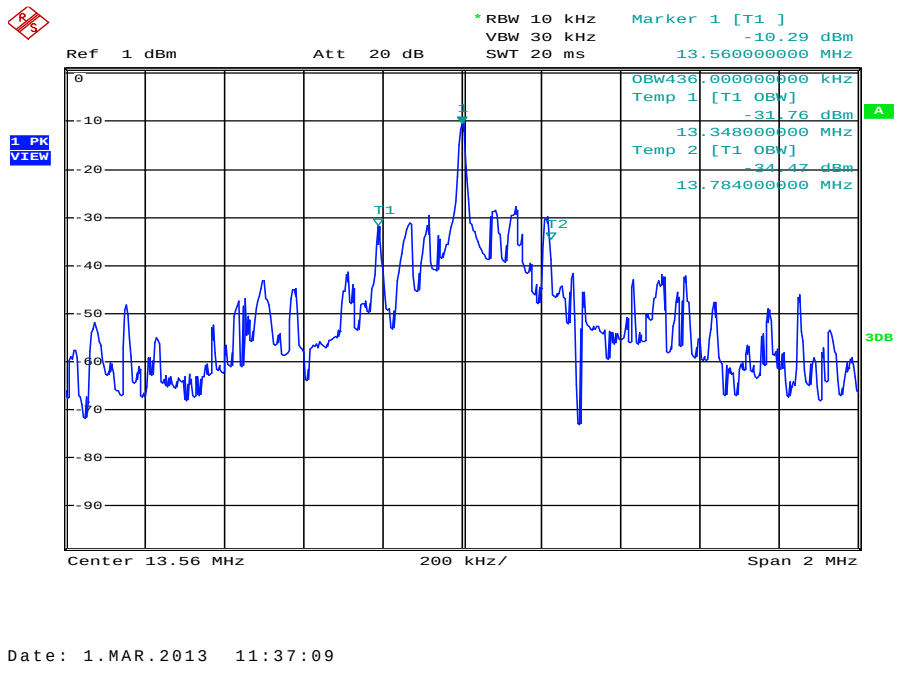
Measurement:

Measurement parameter	
Detector:	Peak
Resolution bandwidth:	10 kHz
Video bandwidth:	≥ RBW
Trace-Mode:	Max Hold

Results:

TEST CONDITIONS		99 % emission bandwidth
Frequency		13.56 MHz
T_{nom}	V_{nom}	436
Measurement uncertainty		± RBW

Plot:



Date: 1.MAR.2013 11:37:09

10.4 Field strength of the harmonics and spurious

Measurement:

Measurement parameter	
Detector:	Quasi Peak / Average
Sweep time:	Auto
Resolution bandwidth:	120 kHz
Video bandwidth:	300 kHz
Span:	See plots!
Trace-Mode:	Max hold

Limits:

FCC		IC
Field strength of the harmonics and spurious.		
Frequency (MHz)	**Field strength (µV/m)**	**Measurement distance (m)**
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30	30 (29.5 dBµV/m)	30
30 – 88	100 (40 dBµV/m)	3
88 – 216	150 (43.5 dBµV/m)	3
216 – 960	200 (46 dBµV/m)	3

Result:

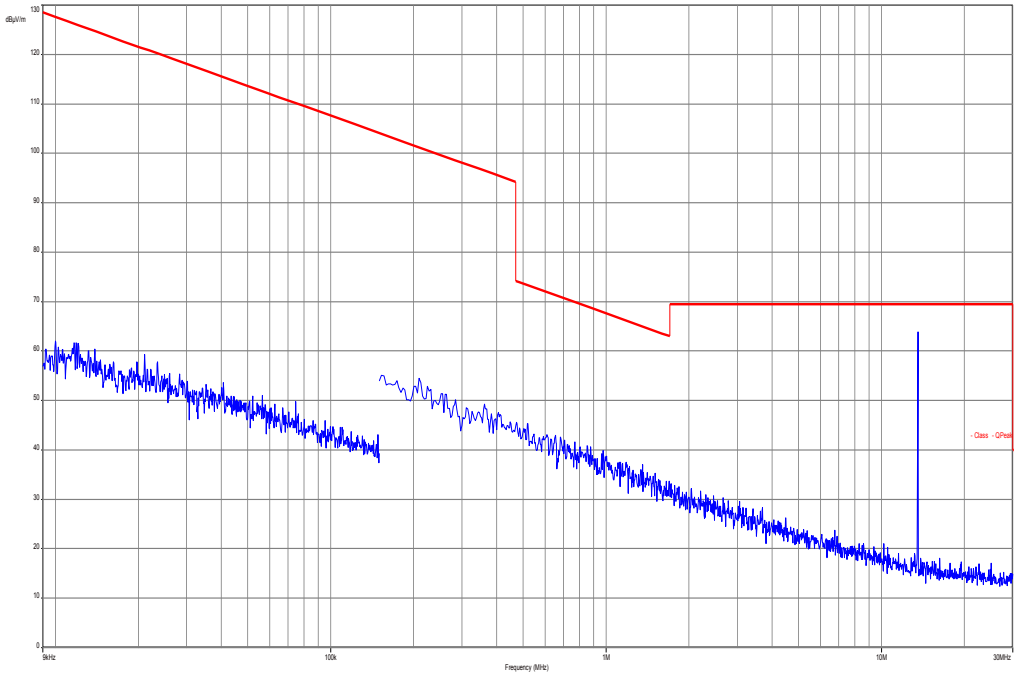
EMISSION LIMITATIONS				
f [MHz]	Detector	Limit max. allowed [dBµV/m]	Amplitude of emission [dBµV/m]	Results
No peaks found higher than 10 dB below the limit				

Result: passed

Plots of the measurements

Plot 1: 9 kHz – 30 MHz; Part 15.209 Magnetics, Measurement distance 3m

Transmit frequency 13.56 MHz



Plot 2: 30 MHz – 1000 MHz

Transmit frequency 13.56 MHz

CETECOM ICT Services GmbH

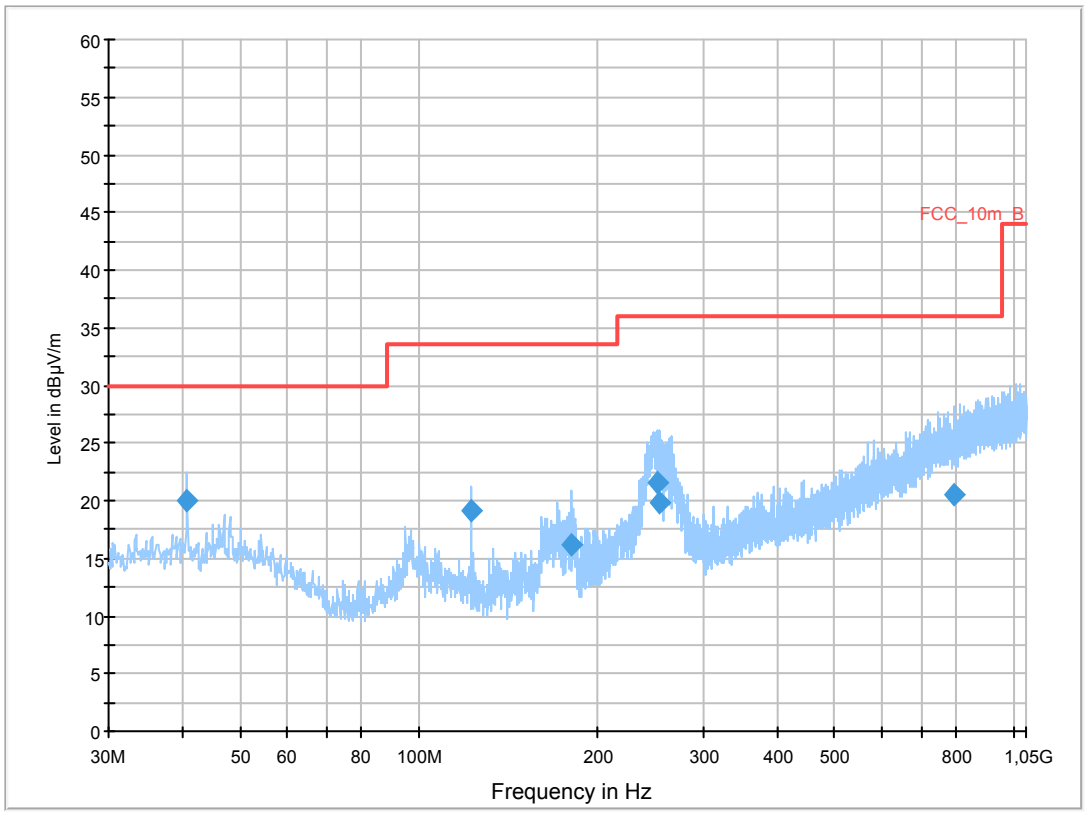
Common Information

EUT:	Keypad1-EXT
Serial Number:	unknown
Test Description:	FCC part 15 class B @ 10 m
Operating Conditions:	cond. TX
Operator Name:	Hennemann
Comment:	DC: 24 V

Scan Setup: STAN_Fin [EMI radiated]

Hardware Setup:	Electric Field (NOS)
Receiver:	[ESCI 3]
Level Unit:	dBµV/m

Subrange	Step Size	Detectors	IF BW	Meas. Time	Preamp
30 MHz - 2 GHz	60 kHz	QPK	120 kHz	1 s	20 dB



Final Result 1

Frequency (MHz)	QuasiPeak (dBµV/m)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)	Corr. (dB)	Margin (dB)	Limit (dBµV/m)	Comment
40.683600	19.9	1000.0	120.000	105.0	V	270.0	13.4	10.1	30.0	
122.031300	19.2	1000.0	120.000	162.0	V	100.0	10.1	14.3	33.5	
179.959500	16.2	1000.0	120.000	98.0	V	175.0	10.4	17.3	33.5	
251.935350	21.6	1000.0	120.000	157.0	V	10.0	13.4	14.4	36.0	
254.392350	19.8	1000.0	120.000	111.0	V	10.0	13.4	16.2	36.0	
795.503550	20.5	1000.0	120.000	153.0	H	90.0	23.8	15.5	36.0	

Hardware Setup: EMI radiated\Electric Field (NOS) - [EMI radiated]

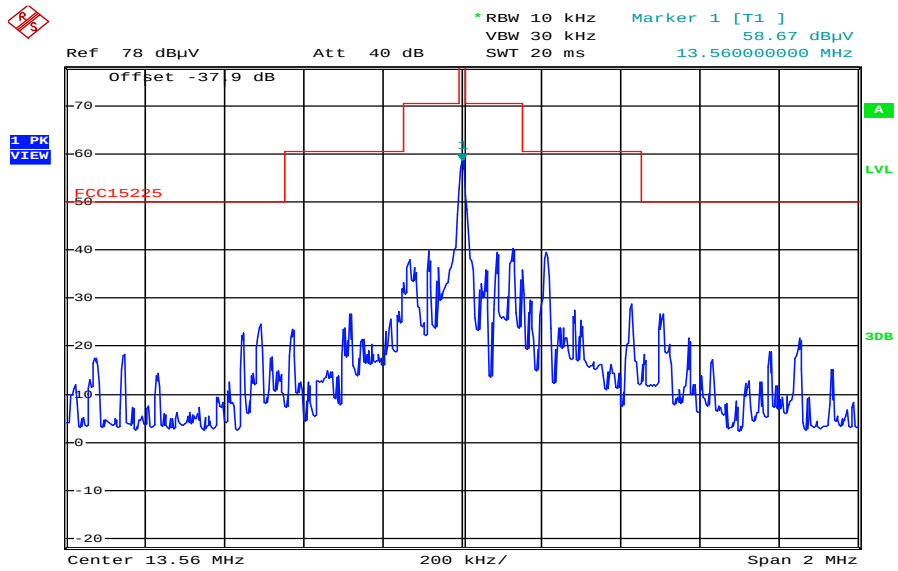
Subrange 1

Frequency Range:	30 MHz - 2 GHz
Receiver:	Receiver [ESCI 3] @ GPIB0 (ADR 20), SN 100083/003, FW 4.42
Signal Path:	without Notch FW 1.0
Antenna:	VULB 9163 SN 9163-295, FW --- Correction Table (vertical): VULP6113 Correction Table (horizontal): VULP6113 Correction Table (vertical): Cable_EN_1GHz (1005) Correction Table (horizontal): Cable_EN_1GHz (1005)
Antenna Tower:	Tower [EMCO 2090 Antenna Tower] @ GPIB0 (ADR 8), FW REV 3.12
Turntable:	Turntable [EMCO Turntable] @ GPIB0 (ADR 9), FW REV 3.12

EMC 32 Version 8.52

Plot 3: Spectrum mask part15.225 (a, b, c, d)

Limits recalculated from 30 m to 10 m with 40 dB/decade according to FCC 15.31 (f2)



The transmitter holds the requirements of FCC 15.225 (a, b, c and d)

10.5 Frequency tolerance

Measurement:

Measurement parameter	
Detector:	Positive peak
Sweep time:	Auto
Resolution bandwidth:	10 Hz
Video bandwidth:	1 MHz
Span:	1 kHz
Trace-Mode:	Clear – write

Limits:

FCC	IC
The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of -20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C.	

Result: passed

Frequency tolerance								
Over temperature variation			Over voltage variation					
Limit is +/- 1.356 kHz			Limit is +/- 1.356 kHz			-/-		
T (°C)]	Frequency	result	Power voltage	Frequency	result	F [MHz]	Detector	Level [µV/m]
-20°	13.56051	Pass	20 V	13.56047	Pass	-/-		
-10°	13.56049	Pass	24 V	13.56046	Pass			
0°	13.56049	Pass	28 V	13.56046	Pass			
10°	13.56049	Pass	32 V	13.56046	Pass			
20°	13.56045	Pass	36 V	13.56046	Pass			
30°	13.56043	Pass	40 V	13.56046	Pass			
40°	13.56041	Pass	44 V	13.56046	Pass			
50°	13.56040	Pass	48 V	13.56046	Pass			
55°	13.56040	Pass	50 V	13.56046	Pass			
			54 V	13.56045	Pass			
Measurement uncertainty			±100 Hz					

10.6 Conducted emissions < 30 MHz (AC line conducted)

Measurement:

Measurement parameter	
Detector:	Peak / Quasi peak / Average
Sweep time:	Auto
Resolution bandwidth:	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth:	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span:	9 kHz to 30 MHz
Trace-Mode:	Max hold

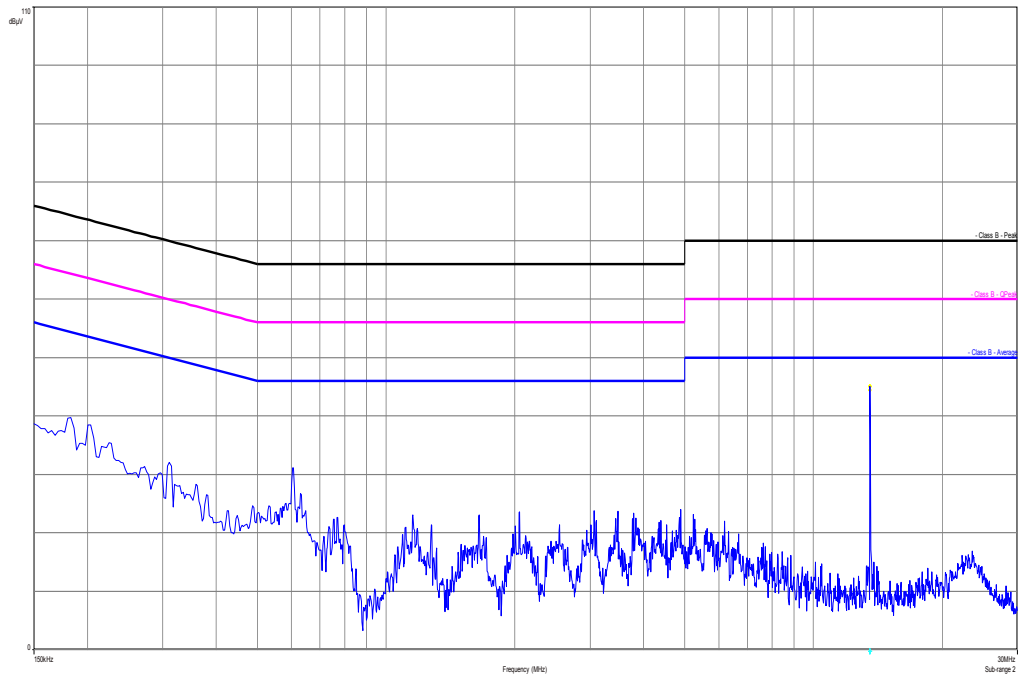
Limits:

FCC	IC	
Frequency of Emission (MHz)	**Conducted Limit (dBµV)**	
	Quasi-peak	Average
0.15 – 0.5	66 to 56 *	56 to 46 *
0.5 – 5	56	46
5 - 30	60	50

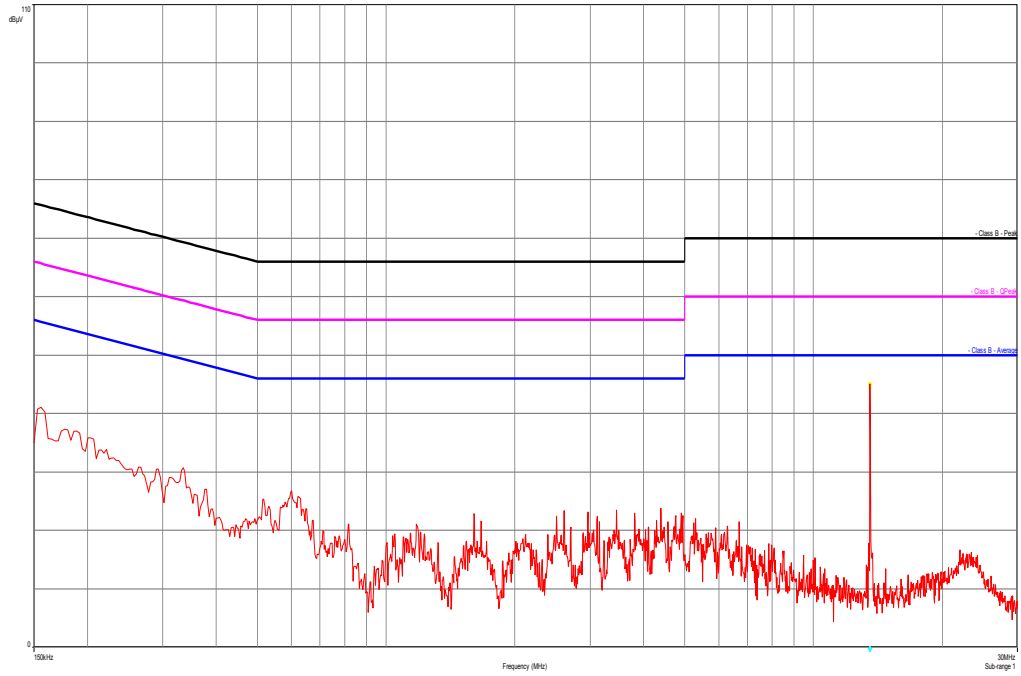
Result: passed

Plots:

Plot 1: phase line



Plot 2: neutral line



11 Test equipment and ancillaries used for tests

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, rf-generating and signalling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Labor/Item).

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	ECT-0002	Temperature and Climatic Test Chamber	VUK04/1500	Heraeus Voetsch	31098	300001507	ev	20.09.2011	20.09.2013
2	n. a.	Power Supply	LA30/5GA	Zentro Elektronik	2046	300000711	NK!		
3	n. a.	EMI Test Receiver 9 kHz - 3 GHz incl. Preselector	ESPI3	R&S	101713	300004059	k	22.08.2012	22.08.2013
4	n. a.	Active Loop Antenna	6502	EMCO	2210	300001015	k	05.06.2013	05.06.2015
5	n. a.	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev		
6	n. a.	Switch / Control Unit	3488A	HP Meßtechnik	*	300000199	ne		
7	n. a.	Switch / Control Unit	3488A	HP Meßtechnik	2719A15013	300001156	ne		
8	n. a.	Three-Way Power Splitter, 50 Ohm	11850C	HP Meßtechnik		300000997	ne		
9	n. a.	Amplifier	js42-00502650-28-5a	Parzich GMBH	928979	300003143	ne		
10	n. a.	Band Reject filter	WRCG1855/1910-1835/1925-40/8SS	Wainwright	7	300003350	ev		
11	n. a.	Band Reject filter	WRCG2400/2483-2375/2505-50/10SS	Wainwright	11	300003351	ev		
12	n. a.	Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	300003789	ne		
13	n. a.	MXE EMI Receiver 20 Hz bis 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	k	19.12.2011	25.02.2014

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
vlkl!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

12 Observations

No observations exceeding those reported with the single test cases have been made.

Annex A Document history

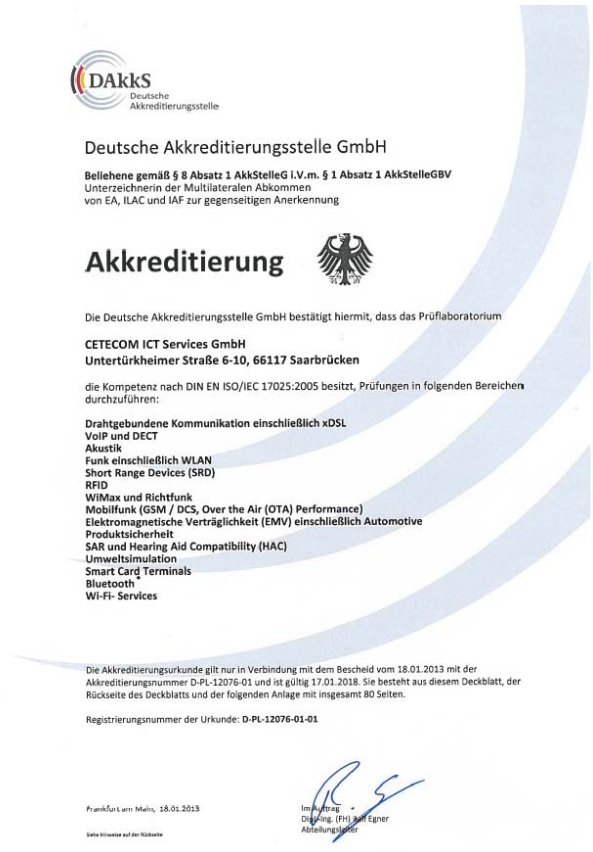
Version	Applied changes	Date of release
1.0	Initial release	2013-05-06
-A	Editorial changings	2013-06-28
-B	Photos extracted in separate Annex files	2013-07-10

Annex B Further information

Glossary

AVG - Average
DUT - Device under test
EMC - Electromagnetic Compatibility
EN - European Standard
EUT - Equipment under test
ETSI - European Telecommunications Standard Institute
FCC - Federal Communication Commission
FCC ID - Company Identifier at FCC
HW - Hardware
IC - Industry Canada
Inv. No. - Inventory number
N/A - Not applicable
PP - Positive peak
QP - Quasi peak
S/N - Serial number
SW - Software

Annex C Accreditation Certificate



DAkkS Deutsche Akkreditierungsstelle

Deutsche Akkreditierungsstelle GmbH

Beliehene gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV
Unterzeichnerin der Multilateralen Abkommen
von EA, ILAC und IAF zur gegenseitigen Anerkennung

Akkreditierung

Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CETECOM ICT Services GmbH
Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:

Drahtgebundene Kommunikation einschließlich xDSL
VoIP und DECT
Akustik
Funk einschließlich WLAN
Short Range Devices (SRD)
RFID
WiMax und Richtfunk
Mobilfunk (GSM / DCS, Over the Air (OTA) Performance)
Elektromagnetische Verträglichkeit (EMV) einschließlich Automotive
Produktsicherheit
SAR und Hearing Aid Compatibility (HAC)
Umweltsimulation
Smart Card Terminals
Bluetooth
Wi-Fi- Services

Die Akkreditierungsurkunde gilt nur in Verbindung mit dem Bescheid vom 18.01.2013 mit der Akkreditierungsnummer D-PL-12076-01 und ist gültig 17.01.2018. Sie besteht aus diesem Deckblatt, der Rückseite des Deckblatts und der folgenden Anlage mit insgesamt 80 Seiten.

Registrierungsnummer der Urkunde: **D-PL-12076-01**

Frankfurt am Main, 18.01.2013

Im Auftrag
Dipl.-Ing. (FH) Jan Egner
Abteilungsleiter

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Die Akkreditierung erfolgte gemäß des Gesetzes über die Akkreditierungsstelle (AkkStelleG) vom 31. Juli 2009 (BGBl. I S. 2625) sowie der Verordnung (EG) Nr. 765/2008 des Europäischen Parlaments und des Rates vom 9. Juli 2008 über die Vorschriften für die Akkreditierung und Marktüberwachung im Zusammenhang mit der Vermarktung von Produkten (Abl. L 218 vom 9. Juli 2008, S. 30).
Die DAkkS ist Unterzeichnerin der Multilateralen Abkommen zur gegenseitigen Anerkennung der European co-operation for Accreditation (EA), des International Accreditation Forum (IAF) und der International Laboratory Accreditation Cooperation (ILAC). Die Unterzeichner dieser Abkommen erkennen ihre Akkreditierungen gegenseitig an.

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ILAC: www.ilac.org
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Note:
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